

Vishay Siliconix

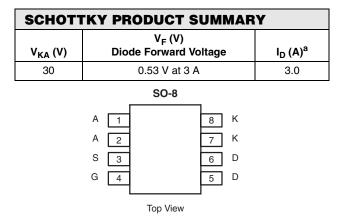
RoHS

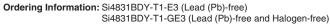
COMPLIANT HALOGEN

Available

P-Channel 30-V (D-S) MOSFET with Schottky Diode

MOSFET PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^a	Q _g (Typ.)		
- 30	0.042 at V _{GS} = - 10 V	- 6.6	7.0		
	0.065 at V _{GS} = - 4.5 V	- 5.3	7.8		



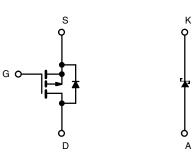


FEATURES

- Halogen-free According to IEC 61249-2-21
 Available
- LITTLE FOOT[®] Plus Power MOSFET
- 100 % R_g Tested

APPLICATIONS

- HDD
- Asynchronous Rectification



P-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $T_A = 25$	°C, unless oth	erwise noted			
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage (MOSFET)	V _{DS}	- 30			
Reverse Voltage (Schottky)		V _{KA}	- 30	V	
Gate-Source Voltage (MOSFET)		V _{GS}	± 20		
	T _C = 25 °C		- 6.6		
Continuous Drain Current (T, = 150 °C) (MOSFET)	T _C = 70 °C	I_	- 5.2		
	T _A = 25 °C	I _D	- 5.1 ^{b, c}		
	T _A = 70 °C		- 3.9 ^{b, c}		
Pulsed Drain Current (MOSFET)		I _{DM}	- 30	A	
Continuous Source Current (MOSFET Diode Conduction)	T _C = 25 °C	I _S	- 2.7		
Continuous Source Current (MOSFET Diode Conduction)	T _A = 25 °C		- 1.6 ^{b, c}		
Average Forward Current (Schottky)	I _F		- 3 ^b		
Pulsed Forward Current (Schottky)		I _{FM}	- 20		
	T _C = 25 °C		3.3		
	T _C = 70 °C	PD	2.1	w	
Maximum Power Dissipation (MOSFET and Schottky)	T _A = 25 °C	טי	2.0 ^{b, c}	vv	
	T _A = 70 °C		1.2 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter	Symbol	Typical	Maximum	Unit		
Maximum Junction-to-Ambient (MOSFET and Schottky) ^{b, c, d}	ky) ^{b, c, d} R _{thJA} 53 62.5		°C/W			
Maximum Junction-to-Foot (Drain) (MOSFET and Schottky)	R _{thJF}	30	37	C/W		

Notes:

a. Based on $T_C = 25 \ ^{\circ}C$.

b. Surface Mounted on FR4 board. c. $t \le 10$ s.

d. Maximum under Steady State conditions is 110 °C/W.

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Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					1		
Drain-Source Breakdown Voltage	V _{DS}	$V_{DS} = 0 V, I_{D} = -250 \mu A$	- 30			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS/TJ}$	L 050 ··· A		- 30			
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)/TJ}$	I _D = 250 μA		3.6		mV/°C	
Gate Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \ \mu A$	- 1		- 3	V	
Gate-Body Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
7 0	I _{DSS}	V _{DS} = - 30 V, V _{GS} = 0 V			- 1		
Zero Gate Voltage Drain Current		V_{DS} = - 30 V, V_{GS} = 0 V, T_{J} = 75 °C			- 10	μΑ	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge -5 V$, $V_{GS} = -10 V$	- 10			Α	
		V _{GS} = - 10 V, I _D = - 5 A		0.034	0.042		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V_{GS} = - 4.5 V, I _D = - 3 A		0.052	0.065	Ω	
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 15 V, I _D = - 5 A		11		S	
Dynamic ^b							
Input Capacitance	C _{iss}			625			
Output Capacitance	C _{oss}			150		pF	
Reverse Transfer Capacitance	C _{rss}	$V_{DS} = -15 \text{ V}, V_{GS} = 0 \text{ V}, \text{ f} = 1 \text{ MHz}$		115			
Total Gate Charge	Qg	V_{DS} = - 15 V, V_{GS} = - 10 V, I_{D} = - 5 A		17	26	nC	
				7.8	12		
Gate-Source Charge	Q _{gs}	V_{DS} = - 15 V, V_{GS} = - 4.5 V, I_{D} = - 5 A		1.6			
Gate-Drain Charge	Q _{gd}			3.5			
Gate Resistance	Rg	f = 1 MHz		7	14	Ω	
Turn-On Delay Time	t _{d(on)}			35	55		
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3 Ω		100	150	1	
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 5 A, V_GEN = - 4.5 V, R_g = 1 Ω		22	35		
Fall Time	t _f			12	20		
Turn-On Delay Time	t _{d(on)}			8	16	ns	
Rise Time	t _r	V_{DD} = - 15 V, R_L = 3 Ω		8	16		
Turn-Off Delay Time	t _{d(off)}	$\text{I}_\text{D}\cong$ - 5 A, V_GEN = - 10 V, R_g = 1 Ω		24	40		
Fall Time	t _f			7	14		
Drain-Source Body Diode Characteristi	cs			1	<u> </u>		
Continous Source-Drain Diode Current	۱ _S	T _C = 25 °C			- 3.3	٨	
Pulse Diode Forward Current ^a	I _{SM}				- 30	A	
Body Diode Voltage	V _{SD}	I _S = - 1.4 A, V _{GS} = 0 V		- 0.78	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			30	45	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	L = 0.0 dl/dt = 100.0/m = 0.0000		15	25	nC	
Reverse Recovery Fall Time	t _a	$I_F = -2 \text{ A}, \text{ dI/dt} = 100 \text{ A/}\mu\text{s}, \text{ T}_J = 25 \text{ °C}$		14			
Reverse Recovery Rise Time	t _b			16		ns	

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.



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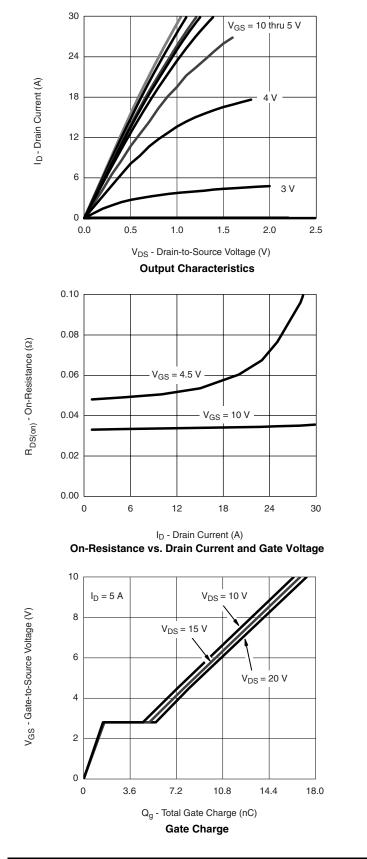
SCHOTTKY SPECIFICATIONS $T_J = 25 \text{ °C}$, unless otherwise noted						
Parameter	Symbol	Test Conditions Min.		Тур.	Max.	Unit
Forward Voltage Drop	VF	I _F = 3 A		0.485	0.53	v
rolward voltage blop	۴F	I _F = 3 A, T _J = 125 °C		0.42	0.47	
Maximum Reverse Leakage Current		V _R = 30 V		0.008	0.1	
	I _{rm}	V _R = 30 V, T _J = 75 °C		0.4	5	mA
		V _R = 30 V, T _J = 125 °C		6.5	20	
Junction Capacitance	CT	V _R = 15 V		102		pF

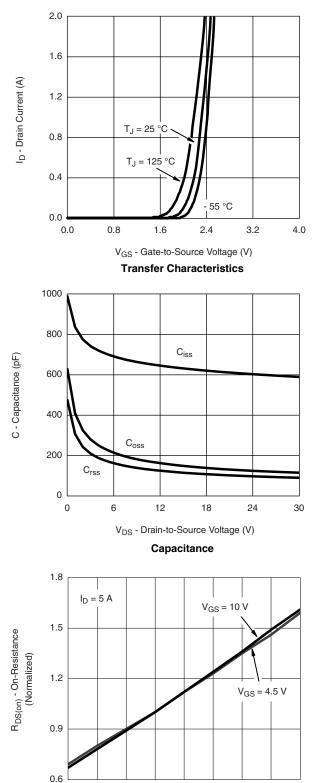
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

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MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted





75

- 50

- 25

0

25

100

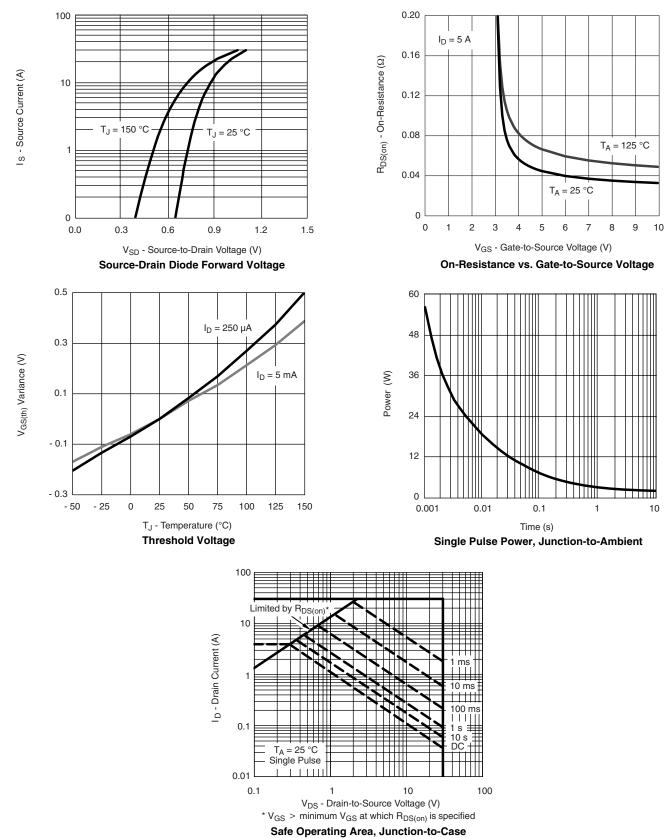
125

150



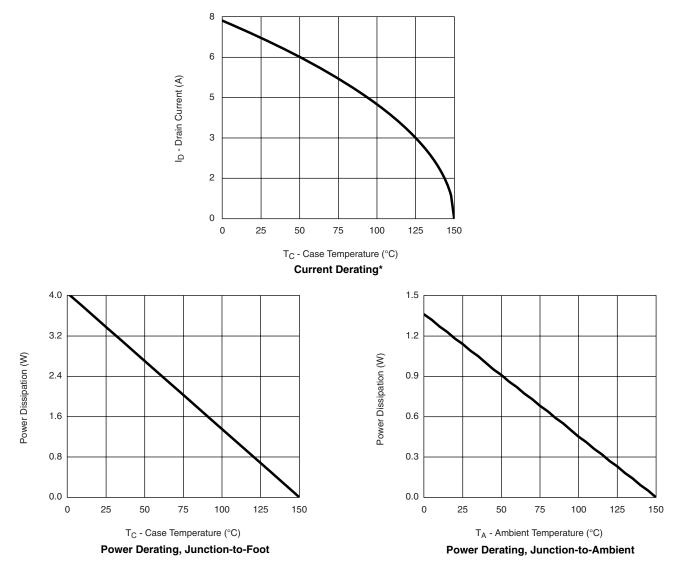
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MOSFET TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



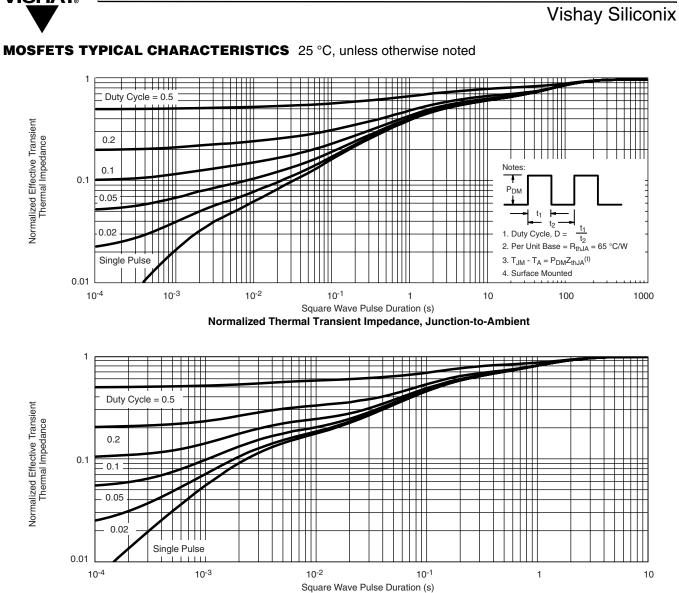
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* The power dissipation PD is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





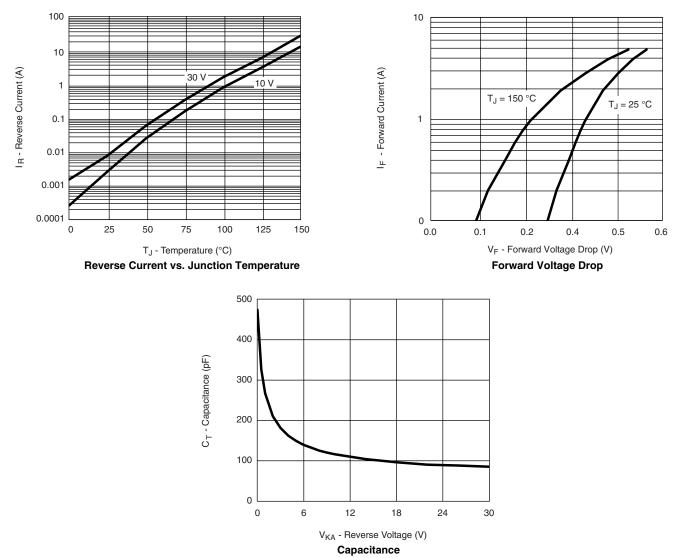
Normalized Thermal Transient Impedance, Junction-to-Foot

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Si4831BDY

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SCHOTTKY TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted



Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppg?70483.



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